SEP 2 6 2003 U SHEET 1 OF 1

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 239558US2	SERIAL NO. 10/606,755				
APPLICANT								
				Satoshi AIDA, et al.				
				FILING DATE		2813		
				June 27, 2003				
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME ·	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
097	AA	6,410,958	06/25/2002	Y. USUI, et al.				
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(A)	AK	10-223896 -	08/21/98	JAPAN (with English Abstract)		<u> </u>	X	
CAT	AL	8-222735	08/30/96	JAPAN (with English Abstract)			X	
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	AW					`\		
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1	AX							
	AY							
	AZ	Additional References sheet(s) attached						
Examiner	Examiner Crong O. Danna					Date Considered 9/27/04		
*Examiner: In	*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							